



Sheet 1 of 3

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

107439-00092

SERIAL NO.

10/643,931

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT

KURODA et al

FILING DATE

August 20, 2003

GROUP

3682

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO PART.		
	AG	2001-182814	7/6/2001	Japan			XX		
	AH	2003-278901	10/2/2003	Japan					XX
	AI	2003-262266	9/19/2003	Japan					XX
	AJ	2003-074683	3/12/2003	Japan					XX
	AK	2003-172444	6/20/2003	Japan					XX
	AL	2003-172165	6/20/2003	Japan					XX

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AM	
	AN	
	AO	

EXAMINER

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		FILING DATE August 20, 2003	GROUP 3682

U.S. PATENT DOCUMENTS

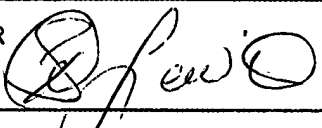
EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	BA						
	BB						
	BC						
	BD						
	BE						
	BF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO PART.		
	BG	2002-115579	4/19/2002	Japan					XX
	BH	2000-264096	9/26/2000	Japan					XX
	BI	2000-052816	2/22/2000	Japan					XX
	BJ	2002-039353	2/6/2002	Japan					XX
	BK	11-303981	2-11/2/1999	Japan					XX
	BL	2001-099282	4/10/2001	Japan					XX

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	BM	
	BN	
	BO	

EXAMINER 	DATE CONSIDERED 12/5/05
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EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	CA						
	CB						
	CC						
	CD						
	CE						
	CF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO PART		
	CG	08-014076	1/16/1996	Japan					XX
	CH	2002-309985	10/23/2002	Japan					XX
	CI	2003-240110	8/27/2003	Japan					XX
	CJ	2003-294122	10/15/2003	Japan					XX
	CK								
	CL								

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	CM	
	CN	
	CO	

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